MC145145-2

4-Bit Data Bus Input PLL Frequency Synthesizer Interfaces with Single–Modulus Prescalers

The MC145145–2 is programmed by a 4–bit input, with strobe and address lines. The device features consist of a reference oscillator, 12–bit programmable reference divider, digital phase detector, 14–bit programmable divide–by–N counter, and the necessary latch circuitry for accepting the 4–bit input data. When combined with a loop filter and VCO, the MC145145–2 can provide all of the remaining functions for a PLL frequency synthesizer operating up to the device frequency limit. For higher VCO frequency operation, a down mixer or a fixed divide prescaler can be used between the VCO and the MC145145–2.

The MC145145–2 is an improved performance drop–in replacement for the MC145145–1. Power consumption has decreased and ESD and latch–up performance have improved.

- Operating Temperature Range: 40 to 85°C
- Low Power Consumption Through the Use of CMOS Technology
- 3.0 to 9.0 V Supply Range
- Single Modulus 4-Bit Data Bus Programming
- On- or Off-Chip Reference Oscillator Operation
- ÷N Range = 3 to 16,383, ÷R Range = 3 to 4,095
- "Linearized" Digital Phase Detector Enhances Transfer Function Linearity
- Two Error Signal Options:
 - Single–Ended (Three–State) Double–Ended
- Chip Complexity: 5,692 FETs or 1,423 Equivalent Gates







PIN ASSIGNMENTS									
PLASTIC DIP									
D1 [1●	18	D D2						
D0 [2	17] D3						
f _{in} [3	16] REF _{out}						
v _{ss} [4	15	□ ∳R						
V _{DD} [5	14	φv						
osc _{in} [6	13	Ъю						
osc _{out} [7	12] PD _{out}						
A0 🛙	8	11] sт						
A1 [9	10] A2						
S	OG PAC	KA	GE						
D1 [1●	20] D2						
D0 [2	19] D3						
NC E	3	18] REF _{out}						
f _{in} C	4	17] ¢R						
v _{ss} c	5	16	Ιφν						
V _{DD} [6	15] LD						

	MOTOROLA
\mathcal{M}	MOTOROLA

14 DPDout

12 🛛 A2

11 D NC

13 🛛 ST

OSC_{in} [

OSCout

A0 🛛 9

A1 L

8

10

NC = NO CONNECTION

REV 1 8/95

MAXIMUM RATINGS* (Voltages Referenced to VSS)

Symbol	Parameter	Value	Unit
V _{DD}	DC Supply Voltage	-0.5 to +10	V
V _{in} , V _{out}	Input or Output Voltage (DC or Transient)	-0.5 to V _{DD} +0.5	V
l _{in} , l _{out}	Input or Output Current (DC or Transient), per Pin	±10	mA
IDD, ISS	Supply Current, V_{DD} or V_{SS} Pins	±30	mA
PD	Power Dissipation, per Package†	500	mW
T _{stg}	Storage Temperature	-65 to +150	°C
ТL	Lead Temperature, 1 mm from Case for 10 Seconds	260	°C

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to these high–impedance circuits. For proper operation, V_{in} and V_{out} should be constrained to the range V_{SS} \leq (V_{in} or V_{out}) \leq V_{DD}.

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either V_{SS} or V_{DD}), except for inputs with pull–up devices. Unused outputs must be left open.

* Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the limits in the Electrical Characteristics tables or Pin Descriptions section.

†Power Dissipation Temperature Derating:

Plastic DIP: -12 mW/°C from 65 to 85°C

SOG Package: -7.0 mW/°C from 65 to 85°C

			VDD	-4	D∘C	25	°C	85	°C	
Symbol	Parameter	Test Conditions	V V	Min	Max	Min	Max	Min	Max	Unit
V _{DD}	Power Supply Voltage Range		-	3.0	9.0	3.0	9.0	3.0	9.0	V
I _{SS}	Dynamic Supply Current	$f_{in} = OSC_{in} = 10 \text{ MHz},$ 1 V p–p ac coupled sine wave R = 128, A = 32, N = 128	3.0 5.0 9.0		3.5 10 30		3.0 7.5 24		3.0 7.5 24	mA
ISS	Quiescent Supply Current	V _{in} = V _{DD} or V _{SS} I _{out} = 0 μA	3.0 5.0 9.0		800 1200 1600		800 1200 1600		1600 2400 3200	μΑ
Vin	Input Voltage — f _{in} , OSC _{in}	Input ac coupled sine wave	-	500	—	500	—	500	—	mV p–p
VIL	Low–Level Input Voltage — f _{in} , OSC _{in}	$\begin{array}{lll} V_{Out} \geq 2.1 \ V & \mbox{Input} \\ V_{Out} \geq 3.5 \ V & \mbox{dc coupled} \\ V_{Out} \geq 6.3 \ V & \mbox{square wave} \end{array}$	3.0 5.0 9.0		0 0 0		0 0 0		0 0 0	V
VIH	High–Level Input Voltage — f _{in} , OSC _{in}	$\begin{array}{lll} V_{OUt} \leq 0.9 \ V & \mbox{Input} \\ V_{Out} \leq 1.5 \ V & \mbox{dc coupled} \\ V_{Out} \leq 2.7 \ V & \mbox{square wave} \end{array}$	3.0 5.0 9.0	3.0 5.0 9.0		3.0 5.0 9.0		3.0 5.0 9.0		V
VIL	Low–Level Input Voltage — except f _{in} , OSC _{in}		3.0 5.0 9.0		0.9 1.5 2.7		0.9 1.5 2.7		0.9 1.5 2.7	V
VIH	High–Level Input Voltage — except f _{in} , OSC _{in}		3.0 5.0 9.0	2.1 3.5 6.3		2.1 3.5 6.3		2.1 3.5 6.3		V
l _{in}	Input Current (fin, OSCin)	$V_{in} = V_{DD}$ or V_{SS}	9.0	± 2.0	± 50	± 2.0	± 25	± 2.0	± 22	μA
ΙL	Input Leakage Current (all inputs except f _{in} , OSC _{in})	Vin = VSS	9.0	—	- 0.3	—	- 0.1	—	- 1.0	μΑ
ЧΗ	Input Leakage Current (all inputs except f _{in} , OSC _{in})	V _{in} = V _{DD}	9.0	—	0.3	—	0.1	-	1.0	μA
C _{in}	Input Capacitance		-	—	10	_	10	_	10	pF
VOL	Low–Level Output Voltage— OSC _{out}	$I_{out} \approx 0 \ \mu A$ Vin = VDD	3.0 5.0 9.0		0.9 1.5 2.7		0.9 1.5 2.7		0.9 1.5 2.7	V
VOH	High–Level Output Voltage— OSC _{out}	$I_{out} \approx 0 \ \mu A$ $V_{in} = V_{SS}$	3.0 5.0 9.0	2.1 3.5 6.3		2.1 3.5 6.3		2.1 3.5 6.3		V

ELECTRICAL CHARACTERISTICS (Voltages Referenced to V_{SS})

(continued)

ELECTRICAL CHARACTERISTICS (continued)

			VDD	-40	D°C	25	°C	85	°C	
Symbol	Parameter	Test Conditions	v v	Min	Max	Min	Max	Min	Max	Unit
VOL	Low–Level Output Voltage— Other Outputs	I _{out} ≈0μA	3.0 5.0 9.0		0.05 0.05 0.05		0.05 0.05 0.05		0.05 0.05 0.05	V
VOH	High–Level Output Voltage— Other Outputs	I _{out} ≈0μA	3.0 5.0 9.0	2.95 4.95 8.95		2.95 4.95 8.95		2.95 4.95 8.95		V
IOL	Low–Level Sinking Current— Lock Detect	$V_{out} = 0.3 V$ $V_{out} = 0.4 V$ $V_{out} = 0.5 V$	3.0 5.0 9.0	0.25 0.64 1.3		0.2 0.51 1.0		0.15 0.36 0.7		mA
ЮН	High–Level Sourcing Current—Lock Detect	V _{out} = 2.7 V V _{out} = 4.6 V V _{out} = 8.5 V	3.0 5.0 9.0	-0.25 -0.64 -1.3		-0.2 -0.51 -1.0		-0.15 -0.36 -0.7		mA
IOL	Low–Level Sinking Current— Other Outputs	V _{out} = 0.3 V V _{out} = 0.4 V V _{out} = 0.5 V	3.0 5.0 9.0	0.44 0.64 1.3		0.35 0.51 1.0		0.22 0.36 0.7		mA
ЮН	High–Level Sourcing Current—Other Outputs	V _{out} = 2.7 V V _{out} = 4.6 V V _{out} = 8.5 V	3.0 5.0 9.0	-0.44 -0.64 -1.3		-0.35 -0.51 -1.0		-0.22 -0.36 -0.7		mA
loz	Output Leakage Current— PD _{out}	V _{out} = V _{DD} or V _{SS} Output in Off State	9.0		± 0.3	—	± 0.1		± 1.0	μA
Cout	Output Capacitance — PD _{out}	PD _{out} — Three–State	-	_	10	_	10	_	10	pF

AC ELECTRICAL CHARACTERISTICS (CL = 50 pF, Input $t_f = t_f = 10 \text{ ns}$)

Symbol	Parameter	Figure No.	V _{DD} V	Guaranteed Limit 25°C	Guaranteed Limit -40 to 85°C	Unit
tw	Output Pulse Width, $\phi_R,\phi_V\!,$ and LD with f_R in Phase with f_V	1, 5	3.0 5.0 9.0	25 to 200 20 to 100 10 to 70	25 to 260 20 to 125 10 to 80	ns
tTLH, tTHL	Maximum Output Transition Time, LD	2, 5	3.0 5.0 9.0	180 90 70	200 120 90	ns
tTLH, tTHL	Maximum Output Transition Time, Other Outputs	2, 5	3.0 5.0 9.0	160 80 60	175 100 65	ns
^t su	Minimum Setup Time, Data to ST	3	3.0 5.0 9.0	10 10 10		ns
t _{su}	Minimum Setup Time, Address to ST	3	3.0 5.0 9.0	25 20 15		ns
th	Minimum Hold Time, Address to ST	3	3.0 5.0 9.0	10 10 10	 	ns
th	Minimum Hold Time, Data to ST	3	3.0 5.0 9.0	25 20 15		ns
t _w	Minimum Input Pulse Width, ST	4	3.0 5.0 9.0	40 30 20		ns

SWITCHING WAVEFORMS





* Includes all probe and fixture capacitance.

Figure 5. Test Circuit

FREQUENCY CHARACTERISTICS (Voltages Referenced	to V _{SS} , $C_L = 50$ pF, Input $t_f = t_f = 10$ ns unless otherwise indicated)
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			V _{DD} –40°C 25°		°C 25		85	°C		
Symbol	Parameter	Test Conditions	V	Min	Max	Min	Max	Min	Max	Unit
fi	Input Frequency (f _{in} , OSC _{in})	$\label{eq:relation} \begin{array}{l} R \geq 8, \ A \geq 0, \ N \geq 8 \\ V_{in} = 500 \ \text{mV} \ p\text{p ac coupled} \\ \text{sine wave} \end{array}$	3.0 5.0 9.0		6.0 15 15		6.0 15 15		6.0 15 15	MHz
		$\label{eq:relation} \begin{array}{l} R \geq 8, A \geq 0, N \geq 8 \\ V_{in} = 1.0 V p {-}p \mbox{ ac coupled} \\ sine \mbox{ wave} \end{array}$	3.0 5.0 9.0		12 22 25		12 20 22		7.0 20 22	MHz
		$R \ge 8$, $A \ge 0$, $N \ge 8$ $V_{in} = V_{DD}$ to VSS dc coupled square wave	3.0 5.0 9.0		13 25 25		12 22 25		8.0 22 25	MHz



V_H = High voltage level.

 V_L = Low voltage level. * At this point, when both f_R and f_V are in phase, the output is forced to near mid supply.

NOTE: The PD_{OUt} generates error pulses during out–of–lock conditions. When locked in phase and frequency, the output is high impedance and the voltage at that pin is determined by the low–pass filter capacitor.

Figure 6. Phase/Frequency Detectors and Lock Detector Output Waveforms

INPUT PINS

D0 – D3

Data Inputs (PDIP – Pins 2, 1, 18, 17; SOG – Pins 2, 1, 20, 19)

Information at these inputs is transferred to the internal latches when the ST input is in the high state. D3 is most significant bit.

fin

Frequency Input (PDIP - Pin 3, SOG - Pin 4)

Input to $\div N$ portion of synthesizer. f_{in} is typically derived from the loop VCO and is ac coupled. For larger amplitude signals (standard CMOS–logic levels) dc coupling may be used.

OSCin/OSCout

Reference Oscillator Input/Output (PDIP – Pins 6, 7; SOG – Pins 7, 8)

These pins form an on-chip reference oscillator when connected to terminals of an external parallel resonant crystal. Frequency setting capacitors of appropriate value must be connected from OSC_{in} to ground and OSC_{out} to ground. OSC_{in} may also serve as input for an externally-generated reference signal. This signal is typically ac coupled to OSC_{in}, but for larger amplitude signals (standard CMOSlogic levels) dc coupling may also be used. In the external reference mode, no connection is required to OSC_{out}.

A0 – A2

Address Inputs (PDIP – Pins 8, 9, 10; SOG – Pins 9, 10, 12)

A0, A1, and A2 are used to define which latch receives the information on the data input lines. The addresses refer to the following latches:

A2	A1	A0	Selected	Function	D0	D1	D2	D3
0	0	0	Latch 0	÷ N Bits	0	1	2	3
0	0	1	Latch 1	÷ N Bits	4	5	6	7
0	1	0	Latch 2	÷ N Bits	8	9	10	11
0	1	1	Latch 3	÷ N Bits	12	13	I	
1	0	0	Latch 4	Reference Bits	0	1	2	3
1	0	1	Latch 5	Reference Bits	4	5	6	7
1	1	0	Latch 6	Reference Bits	8	9	10	11
1	1	1	_		_	_	—	_

ST

Strobe Transfer (PDIP - Pin 11, SOG - Pin 13)

The rising edge of strobe transfers data into the addressed latch, the falling edge of strobe latches data into the latch.

This pin should normally be held low to avoid loading latches with invalid data.

OUTPUT PINS

PDout

Single–Ended Phase Detector Output (PDIP – Pin 12, SOG – Pin 14)

Three-state output of phase detector for use as loop-error signal.

Frequency $f_V > f_R$ or f_V Leading: Negative Pulses

Frequency $f_V < f_R$ or f_V Lagging: Positive Pulses

Frequency $f_V\!=\!f_R$ and Phase Coincidence: High–Impedance State

LD

Lock Detector Signal (PDIP - Pin 13, SOG - Pin 15)

High level when loop is locked (f_R , f_V of same phase and frequency). Pulses low when loop is out of lock.

φV, **φR**

Phase Detector Outputs (PDIP – Pins 14, 15; SOG – Pins 16, 17)

These phase detector outputs can be combined externally for a loop–error signal. A single–ended output is also available for this purpose (see PD_{out}).

If frequency f_V is greater than f_R or if the phase of f_V is leading, then error information is provided by ϕ_V pulsing low. ϕ_R remains essentially high.

If the frequency f_V is less than f_R or if the phase of f_V is lagging, then error information is provided by ϕ_R pulsing low. ϕ_V remains essentially high.

If the frequency of $f_V = f_R$ and both are in phase, then both ϕ_V and ϕ_R remain high except for a small minimum time period when both pulse low in phase.

REFout

Buffered Reference Output (PDIP – Pin 16, SOG – Pin 18)

Buffered output of on-chip reference oscillator or externally provided reference-input signal.

POWER SUPPLY PINS

Vss

Ground (PDIP - Pin 4, SOG - Pin 5)

Circuit Ground.

VDD

Positive Power Supply (PDIP - Pin 5, SOG - Pin 6)

The positive supply voltage may range from 3.0 to 9.0 V with respect to VSS.

DESIGN CONSIDERATIONS

PHASE-LOCKED LOOP - LOW-PASS FILTER DESIGN



NOTE: Sometimes R₁ is split into two series resistors, each R₁ ÷ 2. A capacitor C_C is then placed from the midpoint to ground to further filter ϕ_V and ϕ_R . The value of C_C should be such that the corner frequency of this network does not significantly affect ω_n .

DEFINITIONS:

N=Total Division Ratio in feedback loop

 ${\rm K}_\varphi$ (Phase Detector Gain) = $V_{DD}/4\pi$ for ${\rm PD}_{out}$

 K_{ϕ} (Phase Detector Gain) = $V_{DD}/2\pi$ for ϕ_V and ϕ_R

$$K_{VCO}$$
 (VCO Gain) = $\frac{2\pi\Delta I_{VCO}}{\Delta V_{VCO}}$

for a typical design w_n (Natural Frequency) $\approx \frac{2\pi fr}{10}$ (at phase detector input).

Damping Factor: $\zeta \cong 1$

RECOMMENDED READING:

Gardner, Floyd M., Phaselock Techniques (second edition). New York, Wiley-Interscience, 1979.

Manassewitsch, Vadim, *Frequency Synthesizers: Theory and Design (second edition)*. New York, Wiley–Interscience, 1980. Blanchard, Alain, *Phase–Locked Loops: Application to Coherent Receiver Design*. New York, Wiley–Interscience, 1976.

Egan, William F., Frequency Synthesis by Phase Lock. New York, Wiley-Interscience, 1981.

Rohde, Ulrich L., Digital PLL Frequency Synthesizers Theory and Design. Englewood Cliffs, NJ, Prentice-Hall, 1983.

Berlin, Howard M., Design of Phase-Locked Loop Circuits, with Experiments. Indianapolis, Howard W. Sams and Co., 1978.

Kinley, Harold, The PLL Synthesizer Cookbook. Blue Ridge Summit, PA, Tab Books, 1980.

AN535, Phase–Locked Loop Design Fundamentals, Motorola Semiconductor Products, Inc., 1970.

AR254, Phase–Locked Loop Design Articles, Motorola Semiconductor Products, Inc., Reprinted with permission from *Electronic Design*, 1987.

CRYSTAL OSCILLATOR CONSIDERATIONS

The following options may be considered to provide a reference frequency to Motorola's CMOS frequency synthesizers.

Use of a Hybrid Crystal Oscillator

Commercially available temperature–compensated crystal oscillators (TCXOs) or crystal–controlled data clock oscillators provide very stable reference frequencies. An oscillator capable of sinking and sourcing 50 μ A at CMOS logic levels may be direct or dc coupled to OSC_{in}. In general, the highest frequency capability is obtained utilizing a direct–coupled square wave having a rail–to–rail (V_{DD} to V_{SS}) voltage swing. If the oscillator does not have CMOS logic levels on the outputs, capacitive or ac coupling to OSC_{in} may be used. OSC_{OUt}, an unbuffered output, should be left floating.

For additional information about TCXOs and data clock oscillators, please consult the latest version of the *eem Electronic Engineers Master Catalog*, the *Gold Book*, or similar publications.

Design an Off-Chip Reference

The user may design an off-chip crystal oscillator using ICs specifically developed for crystal oscillator applications, such as the MC12061 MECL device. The reference signal from the MECL device is ac coupled to OSC_{in}. For large amplitude signals (standard CMOS logic levels), dc coupling is used. OSC_{out}, an unbuffered output, should be left floating. In general, the highest frequency capability is obtained with a direct-coupled square wave having rail-to-rail voltage swing.

Use of the On–Chip Oscillator Circuitry

The on-chip amplifier (a digital inverter) along with an appropriate crystal may be used to provide a reference source frequency. A fundamental mode crystal, parallel resonant at the desired operating frequency, should be connected as shown in Figure 7.

For V_{DD} = 5.0 V, the crystal should be specified for a loading capacitance, C_L, which does not exceed 32 pF for frequencies to approximately 8.0 MHz, 20 pF for frequencies in the area of 8.0 to 15 MHz, and 10 pF for higher frequencies. These are guidelines that provide a reasonable compromise between IC capacitance, drive capability, swamping variations in stray and IC input/output capacitance, and realistic C_L values. The shunt load capacitance, C_L, presented across the crystal can be estimated to be:

$$C_{L} = \frac{C_{in}C_{out}}{C_{in} + C_{out}} + C_{a} + C_{o} + \frac{C1 \cdot C2}{C1 + C2}$$

where

 $C_{in} = 5.0 \text{ pF} (\text{see Figure 8})$

 $C_{out} = 6.0 \text{ pF} (\text{see Figure 8})$

 $C_a = 1.0 \text{ pF}$ (see Figure 8)

 C_{O} = the crystal's holder capacitance (see Figure 9) C1 and C2 = external capacitors (see Figure 7)

The oscillator can be "trimmed" on-frequency by making a portion or all of C1 variable. The crystal and associated components must be located as close as possible to the OSC_{in}

and OSC_{out} pins to minimize distortion, stray capacitance, stray inductance, and startup stabilization time. In some cases, stray capacitance should be added to the value for C_{in} and C_{out} .

Power is dissipated in the effective series resistance of the crystal, R_e, in Figure 9. The drive level specified by the crystal manufacturer is the maximum stress that a crystal can withstand without damage or excessive shift in frequency. R1 in Figure 7 limits the drive level. The use of R1 may not be necessary in some cases (i.e., R1 = 0 Ω).

To verify that the maximum dc supply voltage does not overdrive the crystal, monitor the output frequency as a function of voltage at OSC_{out}. (Care should be taken to minimize loading.) The frequency should increase very slightly as the dc supply voltage is increased. An overdriven crystal will decrease in frequency or become unstable with an increase in supply voltage. The operating supply voltage must be reduced or R1 must be increased in value if the overdriven condition exists. The user should note that the oscillator start–up time is proportional to the value of R1.

Through the process of supplying crystals for use with CMOS inverters, many crystal manufacturers have developed expertise in CMOS oscillator design with crystals. Discussions with such manufacturers can prove very helpful. (see Table 1).



* May be deleted in certain cases. See text.

Figure 7. Pierce Crystal Oscillator Circuit



Figure 8. Parasitic Capacitances of the Amplifier



NOTE: Values are supplied by crystal manufacturer (parallel resonant crystal).

Figure 9. Equivalent Crystal Networks

Table 1. Partial List of Crystal Manufacturers

Name	Address	Phone
United States Crystal Corp.	3605 McCart Ave., Ft. Worth, TX 76110	(817) 921–3013
Crystek Crystal	2351 Crystal Dr., Ft. Myers, FL 33907	(813) 936–2109
Statek Corp.	512 N. Main St., Orange, CA 92668	(714) 639–7810

NOTE: Motorola cannot recommend one supplier over another and in no way suggests that this is a complete listing of crystal manufacturers.



Figure 10. TV/CATV Tuning System

RECOMMENDED READING

Technical Note TN-24, Statek Corp.

Technical Note TN–7, Statek Corp.

E. Hafner, "The Piezoelectric Crystal Unit – Definitions and Method of Measurement", *Proc. IEEE*, Vol. 57, No. 2 Feb., 1969.

D. Kemper, L. Rosine, "Quartz Crystals for Frequency Control", *Electro–Technology*, June, 1969.

P. J. Ottowitz, "A Guide to Crystal Selection", *Electronic Design*, May, 1966.

APPLICATIONS

The features of the MC145145–2 permit bus operation with a dedicated wire needed only for the strobe input. In a microprocessor–controlled system this strobe input is accessed when the PLL is addressed. The remaining data and address inputs will directly interface to the microprocessor's data and address buses.

The \div R programmability is used to advantage in Figure 10. Here, the nominal \div R value is 3667, but by programming small changes in this value, fine tuning is accomplished. Better tuning resolution is achievable with this method than by changing the \div N, due to the use of the large fixed prescaling value of \div 256 provided by the MC12071.

The two-loop synthesizer, in Figure 11, takes advantage of these features to control the phase-locked loop with a minimum of dedicated lines while preserving optimal loop performance. Both 25 Hz and 100 Hz steps are provided while the relatively large reference frequencies of 10 kHz or 10.1 kHz are maintained.



TO CONTROLLER

NOTES:

1. Table 2 provides program sequence for the \div N1 (Loop 1) and \div N2 (Loop 2) Counters.

2. \div R1 = 1000, f_{R1} = 10.1 kHz, \div R2 = 1010, f_{R2} = 10 kHz. 3. f_{VCO1} = N1(f_{R1}) + N2(f_{R2}) = N1(f_{R2} + Δ f) + N2(f_{R2}) where Δ f = 100 Hz. 4. Other f_{R1} and f_{R2} values may be used with appropriate \div N1 and \div N2 changes.

Figure 11. Two-Loop Synthesizer Provides 25 and 100 Hz Frequency Steps While Maintaining High Detector Comparison Frequencies of 10 and 10.1 kHz

Table 2. Programming Sequence for Two–Loop Synthesizer of Figure 11

÷ N1	f _{in1} (MHz)	÷ N2	f _{VCO2} (MHz)	fvco1 (MHz)
4 396	3.9996	400	4.0000	7.9996
"A" 397	"B" 4.0097	399	3.9900	7.9997
	↓ ↓	↓	↓	↓
▼ 495	4.9995	301	3.0100	8.0095
≜	▲	401	4.0100	8.0096
"A"	"B"	400	4.0000	8.0097
		↓ ↓	↓	*
<u> </u>	¥	303	3.0200	8.0195
	▲	402	4.0200	8.0196
"A"	"В"	"C" 401	"D" 4.0100	8.0197
		*	↓	*
¥	¥	303	3.0300	8.0295
↑				Increasing
"A"	"B"			In 100 Hz Steps
		↓ <u></u>		*
¥	¥	1500	15.0000	19.9995
↑		1600	16.0000	19.9996
"A"	"B"	1599	15.9900	19.9997
		¥ (For	¥	¥
¥	¥	1501	15.0100	20.0095
1585	16.0085	l î	Î Î	20.0085
"E" 1586	"F" 16.0186			20.0086
1684	17.0084			20.0184
1064	17.0084			20.0184
Ť "="	T "F"			20.0185 20.0186
"E"	"F"			20.0186
		"C"	"D"	20.0284
	<u> </u>			Increasing
				In 100 Hz Steps
↓ ↓				32.0084
A	I			32.0085
"E"	"F"			32.0086
				↓ ↓
└────	│	<u> </u>	↓	32.0184

PACKAGE DIMENSIONS

P SUFFIX PLASTIC DIP (DUAL IN–LINE PACKAGE) CASE 707–02



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How to reach us:

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HONG KONG: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park, 51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852–26629298

